

Notice of References Cited	Application/Control No. 10/813,774	Applicant(s)/Patent Under Reexamination CHAN ET AL.	
	Examiner Andrew Wendell	Art Unit 2643	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,748,222	06-2004	Hashem et al.	455/453
*	B	US-2002/0119784	08-2002	Agin, Pascal	455/453
*	C	US-2004/0214574	10-2004	Eyuboglu et al.	455/439
*	D	US-2005/0124347	06-2005	Hosein, Patrick A.	455/446
*	E	US-2005/0176440	08-2005	Sang et al.	455/453
*	F	US-6,895,245	05-2005	Wallentin, Bo Stefan Pontus	455/436
*	G	US-2002/0173315	11-2002	Chmaytelli et al.	455/453
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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